

# PC810

## High Speed Under High Load Resistance Photocoupler

※ Lead forming type ( I type ) and taping reel type ( P type ) are also available. ( PC810I/PC810P )

### ■ Features

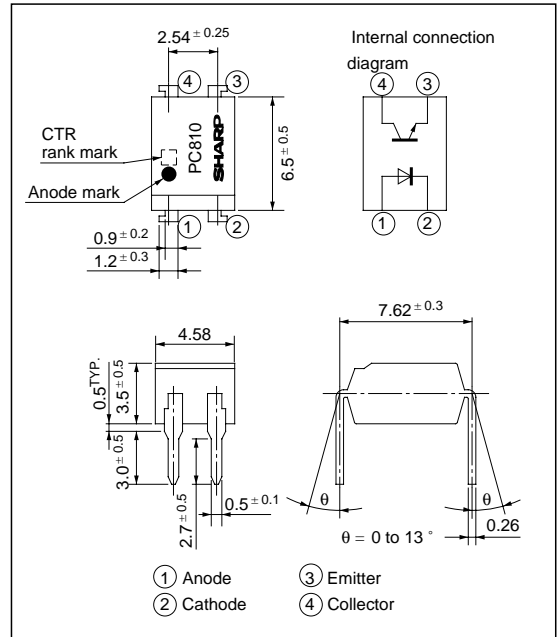
- High speed response under high resistance load  
(  $t_{off}$  : MAX. 1ms at  $I_F = 1\text{mA}$ ,  $V_{CC} = 5\text{V}$ ,  $R_L = 110\text{k}\Omega$  )
- High current transfer ratio under low input current  
( CTR : MIN. 60% at  $I_F = 1\text{mA}$ ,  $V_{CE} = 0.4\text{V}$  )
- High isolation voltage between input and output  
(  $V_{iso}$  : 5 000V<sub>rms</sub> )
- Compact dual-in-line package
- Recognized by UL, file No. E64380

### ■ Applications

- Solid state relays
- Motor-control equipment
- Signal transmission between circuits of different potentials and impedances

### ■ Outline Dimensions

(Unit : mm)



### ■ Absolute Maximum Ratings

( $T_a = 25^\circ\text{C}$ )

	Parameter	Symbol	Rating	Unit
Input	Forward current	$I_F$	50	mA
	*1 Peak forward current	$I_{FM}$	1	A
	Reverse voltage	$V_R$	6	V
	Power dissipation	$P$	70	mW
Output	Collector-emitter voltage	$V_{CEO}$	35	V
	Emitter-collector voltage	$V_{ECO}$	6	V
	Collector current	$I_C$	50	mA
	Collector power dissipation	$P_C$	150	mW
Total power dissipation		$P_{tot}$	200	mW
*2 Isolation voltage		$V_{iso}$	5 000	V <sub>rms</sub>
Operating temperature		$T_{opr}$	- 30 to + 100	$^\circ\text{C}$
Storage temperature		$T_{stg}$	- 55 to + 125	$^\circ\text{C}$
*3 Soldering temperature		$T_{sol}$	260	$^\circ\text{C}$

\*1 Pulse width  $\leq 100\mu\text{s}$ , Duty ratio : 0.001

\*2 40 to 60% RH, AC for 1 minute

\*3 For 10 seconds

**■ Electro-optical Characteristics**

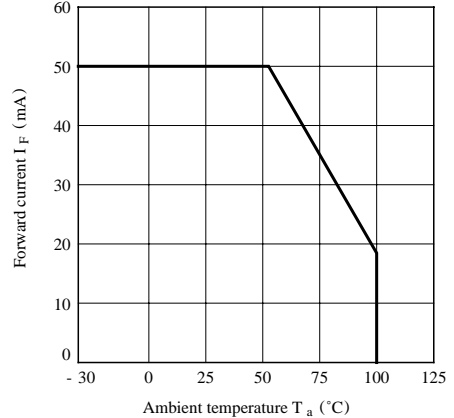
(T<sub>a</sub> = 25°C)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 20mA	-	1.2	1.4	V	
	Peak forward voltage	V <sub>FM</sub>	I <sub>FM</sub> = 0.5A	-	-	3.0	V	
	Reverse current	I <sub>R</sub>	V <sub>R</sub> = 4V	-	-	10	μA	
	Terminal capacitance	C <sub>t</sub>	V = 0, f = 1kHz	-	30	250	pF	
Output	Collector dark current	I <sub>CEO</sub>	V <sub>CE</sub> = 20V, I <sub>F</sub> = 0	-	-	10 <sup>-7</sup>	A	
Transfer characteristics	*5 Current transfer ratio	CTR	I <sub>F</sub> = 1mA, V <sub>CE</sub> = 0.4V	60	-	200	%	
	Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>F</sub> = 20mA, I <sub>C</sub> = 1mA	-	0.1	0.2	V	
	Isolation resistance	R <sub>ISO</sub>	DC500V, 40 to 60% RH	5 × 10 <sup>10</sup>	10 <sup>11</sup>	-	Ω	
	Floating capacitance	C <sub>f</sub>	V = 0, f = 1MHz	-	0.6	1.0	pF	
	Cut-off frequency	f <sub>c</sub>	V <sub>CE</sub> = 5V, I <sub>C</sub> = 2mA, R <sub>L</sub> = 1kΩ, -3dB	6	60	-	kHz	
	*5 Response time	Rise time	t <sub>r</sub>	V <sub>CE</sub> = 2V, I <sub>C</sub> = 2mA, R <sub>L</sub> = 1kΩ	-	10	50	μs
		Fall time	t <sub>f</sub>		-	10	50	μs
*5 Turn-off time		t <sub>off</sub>	V <sub>CC</sub> = 5V, I <sub>F</sub> = 1mA, R <sub>L</sub> = 110kΩ	-	0.5	1.0	ms	

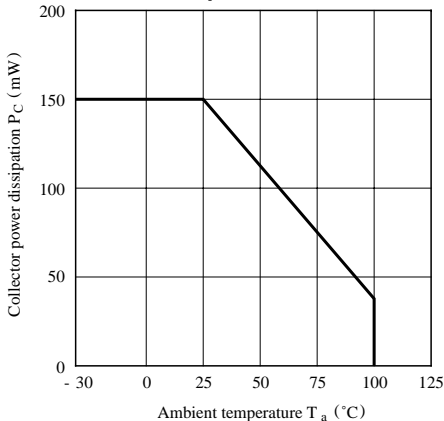
\*5 Classification table of current transfer ratio and response time is shown below

Model No.	Rank mark	CTR (%)	t <sub>r</sub> (μs)		t <sub>f</sub> (μs)		t <sub>off</sub> (μs)	
			TYP.	MAX.	TYP.	MAX.	TYP.	MAX.
PC810A	A	60 to 120	4	15	3	15	350	500
PC810B	B	100 to 200	10	50	10	50	500	1 000
PC810	A or B, or no marking	60 to 200	-	50	-	50	-	1 000
Measurement conditions		I <sub>F</sub> = 1mA V <sub>CE</sub> = 0.4V T <sub>a</sub> = 25°C	V <sub>CE</sub> = 2V I <sub>C</sub> = 2mA R <sub>L</sub> = 1kΩ T <sub>a</sub> = 25°C			I <sub>F</sub> = 1mA V <sub>CC</sub> = 5V R <sub>L</sub> = 110kΩ T <sub>a</sub> = 25°C		

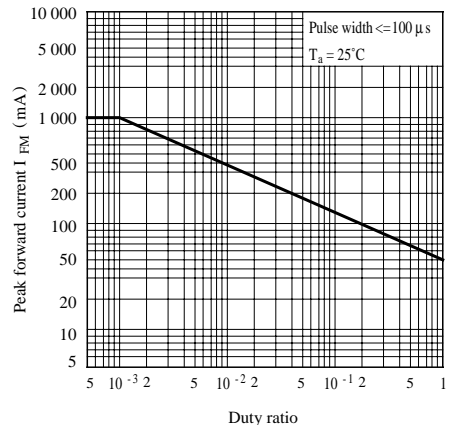
**Fig. 1 Forward Current vs. Ambient Temperature**



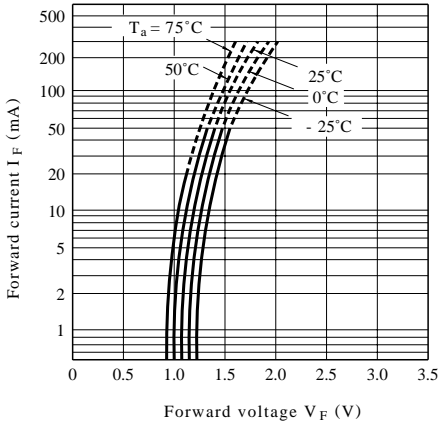
**Fig. 2 Collector Power Dissipation vs. Ambient Temperature**



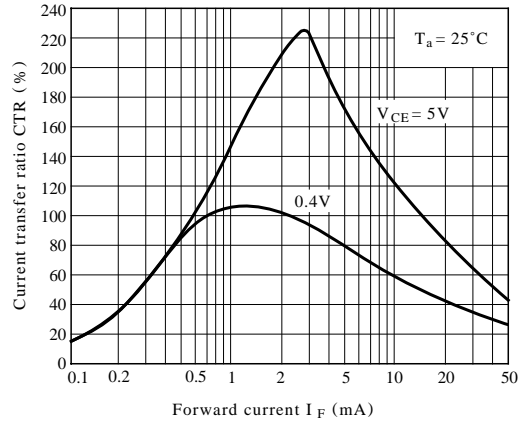
**Fig. 3 Peak Forward Current vs. Duty Ratio**



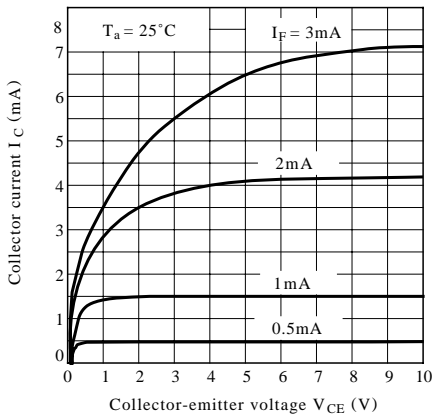
**Fig. 4 Forward Current vs. Forward Voltage**



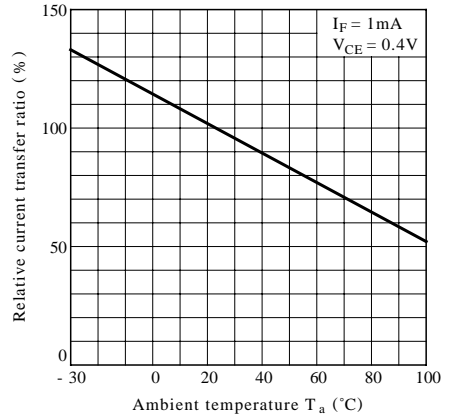
**Fig. 5 Current Transfer Ratio vs. Forward Current**



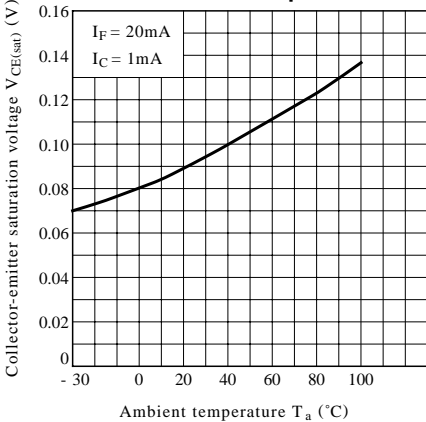
**Fig. 6 Collector Current vs. Collector-emitter Voltage**



**Fig. 7 Relative Current Transfer Ratio vs. Ambient Temperature**



**Fig. 8 Collector-emitter Saturation Voltage vs. Ambient Temperature**



**Fig. 9 Collector Dark Current vs. Ambient Temperature**

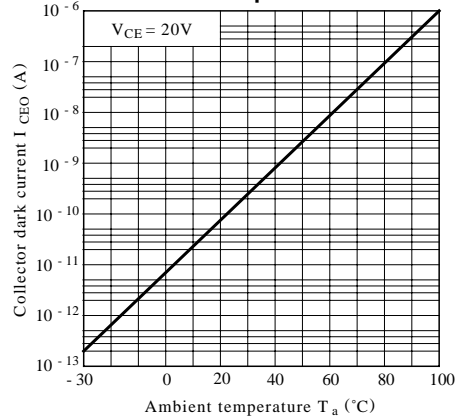


Fig.10 Response Time vs. Load Resistance

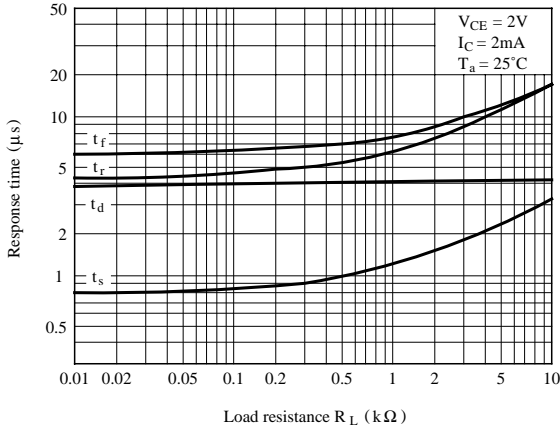


Fig.11 Turn-off Time vs. Load Resistance

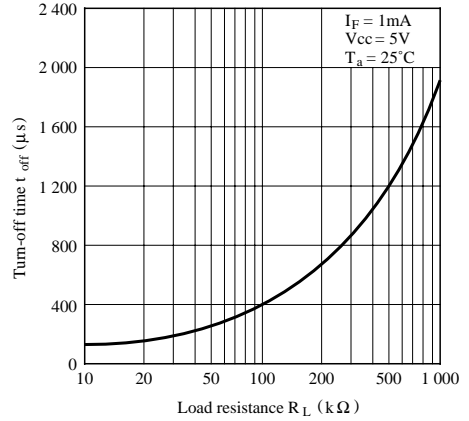


Fig.12 Turn-off Time vs. Ambient Temperature

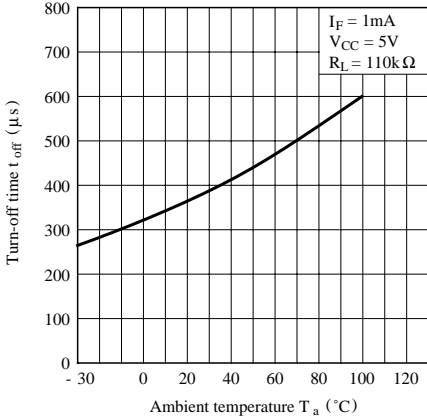
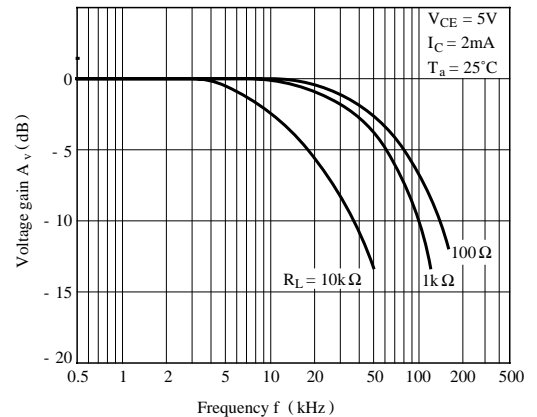
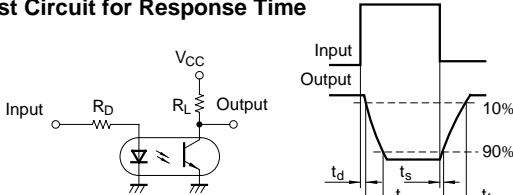


Fig.13 Frequency Response



Test Circuit for Response Time



Test Circuit for Frequency Response

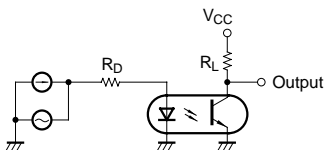
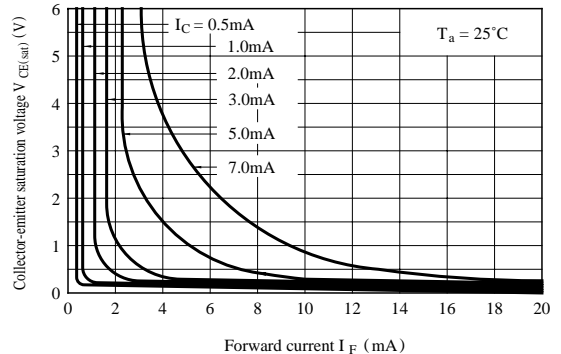


Fig.14 Collector-emitter Saturation Voltage vs. Forward Current



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